





N-CHANNEL ENHANCEMENT MODE MOSFET PLUS NPN TRANSISTOR

Features

- N-Channel MOSFET and NPN Transistor in One Package
- Low On-Resistance
- Very Low Gate Threshold Voltage, 1.0V max
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Ultra-Small Surface Mount Package
- Lead, Halogen and Antimony Free, RoHS Compliant (Note 2)
- ESD Protected MOSFET Gate up to 2kV
- "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SOT-363
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Alloy 42 Lead frame.
 Solderable per MIL-STD-202, Method 208
- Marking Information: See Page 5
- Ordering Information: See Page 5
- Weight: 0.006 grams (approximate)

SOT-363







TOP VIEW
Internal Schematic

TOP VIEW

Maximum Ratings – MOSFET, Q1 @TA = 25°C unless otherwise specified

Charac	teristic	Symbol	Value	Units
Drain-Source Voltage		V_{DSS}	50	V
Gate-Source Voltage		V_{GSS}	±12	V
Drain Current (Note 1)	Continuous	I _D	160	mA
Pulsed Drain Current (Note 1)		I _{DM}	560	mA

Maximum Ratings - NPN Transistor, Q2 @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V _{CBO}	50	V
Collector-Emitter Voltage	V _{CEO}	45	V
Emitter-Base Voltage	V _{EBO}	6.0	V
Collector Current	Ic	100	mA

Thermal Characteristics, Total Device @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 1)	P _D	250	mW
Thermal Resistance, Junction to Ambient (Note 1)	$R_{ hetaJA}$	500	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

Notes:

- 1. Device mounted on FR-4 PCB, 1 inch x 0.85 inch x 0.062 inch; pad layout as shown on Diodes Inc. suggested pad layout document AP02001, which can be found on our website at http://www.diodes.com/datasheets/ap02001.pdf.
- 2. No purposefully added lead. Halogen and Antimony Free.
- 3. Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com/products/lead_free/index.php.



Electrical Characteristics - MOSFET @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 2)						
Drain-Source Breakdown Voltage	BV _{DSS}	50	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	10	μΑ	$V_{DS} = 50V, V_{GS} = 0V$
Gate-Body Leakage	I _{GSS}	_	_	1.0 5.0	μА	$V_{GS} = \pm 8V, V_{DS} = 0V$ $V_{GS} = \pm 12V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 2)						
Gate Threshold Voltage	V _{GS(th)}	0.7	0.8	1.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
Static Drain-Source On-Resistance	0	_	3.1	4	0	$V_{GS} = 4V, I_{D} = 100mA$
Static Drain-Source On-Resistance	R _{DS} (ON)	_	4	5	Ω	$V_{GS} = 2.5V, I_D = 80mA$
Forward Transconductance	9 FS	180	_	_	mS	$V_{DS} = 10V, I_D = 100mA,$ f = 1.0KHz
DYNAMIC CHARACTERISTICS						•
Input Capacitance	C _{iss}	_	25	_	pF	101/11/01/
Output Capacitance	Coss	_	5		pF	$V_{DS} = 10V, V_{GS} = 0V,$ -f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	_	2.1		pF	1 = 1.0ivii iz

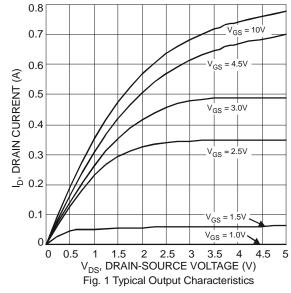
Electrical Characteristics - NPN Transistor @TA = 25°C unless otherwise specified

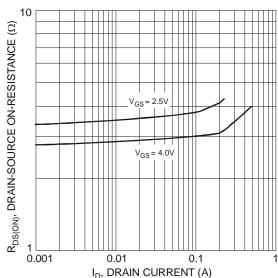
Characteristic		Symbol	Min	Тур	Max	Unit	Test Condition
Collector-Base Breakdown Voltage	(Note 4)	V _{(BR)CBO}	50	_	_	V	$I_C = 10\mu A, I_B = 0$
Collector-Emitter Breakdown Voltage	(Note 4)	V _{(BR)CEO}	45	_	_	V	$I_C = 10 \text{mA}, I_B = 0$
Emitter-Base Breakdown Voltage	(Note 4)	V _{(BR)EBO}	6	_	_	V	$I_E = 1\mu A, I_C = 0$
DC Current Gain	(Note 4)	h _{FE}	200	290	450	_	$V_{CE} = 5.0V, I_{C} = 2.0mA$
Collector-Emitter Saturation Voltage	(Note 4)	V _{CE(SAT)}	1		100 300	mV	$I_C = 10$ mA, $I_B = 0.5$ mA $I_C = 100$ mA, $I_B = 5.0$ mA
Base-Emitter Saturation Voltage	(Note 4)	V _{BE(SAT)}		700 900	_	mV	$I_C = 10 \text{mA}, I_B = 0.5 \text{mA}$ $I_C = 100 \text{mA}, I_B = 5.0 \text{mA}$
Base-Emitter Voltage	(Note 4)	V_{BE}	580 —	660 —	700 770	mV	$V_{CE} = 5.0V, I_{C} = 2.0mA$ $V_{CE} = 5.0V, I_{C} = 10mA$
Collector Cut-Off Current	(Note 4)	I _{CBO}	_	_	15 5.0	nΑ μΑ	V _{CB} = 30V V _{CB} = 30V, T _A = 150°C
Collector-Emitter Cut-Off Current	(Note 4)	I _{CES}	_	_	100	nA	V _{CE} = 45V
Gain Bandwidth Product		f _T	100	_	_	MHz	$V_{CE} = 5.0V$, $I_{C} = 10mA$, $f = 100MHz$
Output Capacitance		C _{OBO}		_	4.5	pF	$V_{CB} = 10V$, $f = 1.0MHz$
Noise Figure		NF	_	_	10	dB	V_{CE} = 5V, R_S = 2.0k Ω , f = 1.0kHz, BW = 200Hz

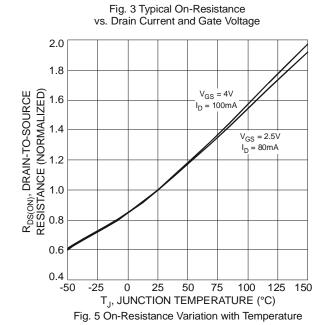
Notes: 4. Short duration pulse test used to minimize self-heating effect.

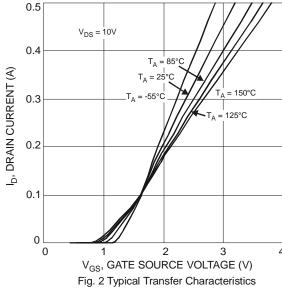


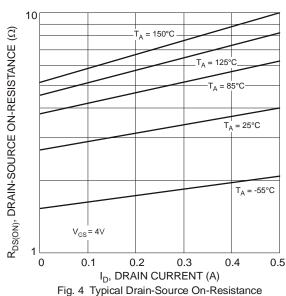
MOSFET











vs. Drain Current and Temperature 35 30 C, CAPACITANCE (pF) 25 20 f = 1MHz $V_{GS} = 0V$ 15 10 5 C_{rss} 0 35 15 20 30 40 0 V_{DS} , DRAIN-SOURCE VOLTAGE (V) Fig. 6 Typical Capacitance



MOSFET (continued)

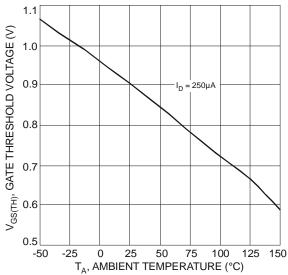


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

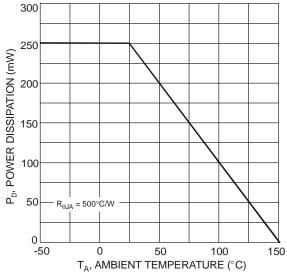
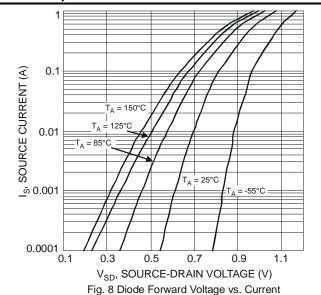


Fig. 9 Derating Curve - Total Package Power Dissipation





NPN Transistor

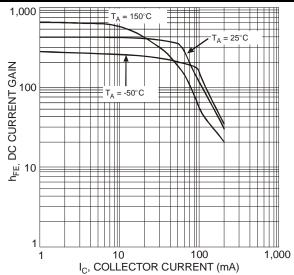


Fig. 10 Typical DC Current Gain vs. Collector Current

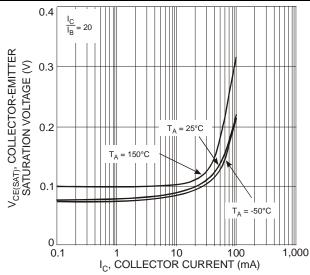
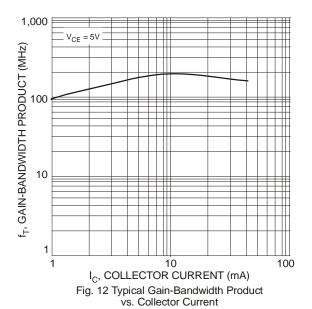


Fig. 11 Typical Collector-Emitter Saturation Voltage vs. Collector Current

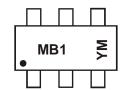


Ordering Information (Note 5)

Ī	Part Number	Case	Packaging	
	DMB53D0UDW-7	SOT-363	3000/Tape & Reel	

Notes: 5. For packaging details, go to our website at http://www.diodes.com/datasheets/ap02007.pdf.

Marking Information



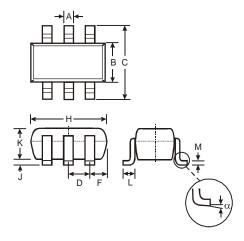
MB1 = Marking Code YM = Date Code Marking Y = Year (ex: V = 2008) M = Month (ex: 9 = September)

Date Code Key

Year	2008		2009	2010		2011	2012		2013	2014		2015
Code	V		W	Х		Υ	Z		Α	В		С
Month	Jan	Feb	Mar	Apr	May	lun	Jul	Aug	Sep	Oct	Nov	Dec
WOITH	Jaii	reb	iviai	Aþi	iviay	Jun	Jui	Aug	Sep	OCI	NOV	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D

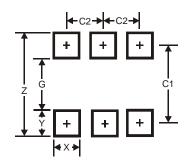


Package Outline Dimensions



	SOT-363							
Dim	Min	Max						
Α	0.10	0.30						
В	1.15	1.35						
С	2.00	2.20						
D	0.65 Typ							
F	0.40	0.45						
Н	1.80	2.20						
J	0	0.10						
K	0.90	1.00						
L	0.25	0.40						
M	0.10	0.22						
α	0°	8°						
All Dimensions in mm								

Suggested Pad Layout



Dimensions	Value (in mm)
Z	2.5
G	1.3
Х	0.42
Υ	0.6
C1	1.9
C2	0.65



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